

Normally – OFF Silicon Carbide Junction Transistor

V _{DS}	=	1200 V
R _{DS(ON)}	=	25 mΩ
I _{D (Tc = 25°C)}	=	100 A
I _{D (Tc > 125°C)}	=	50 A
h _{FE (Tc = 25°C)}	=	95

Features

- 175 °C Maximum Operating Temperature
- Gate Oxide Free SiC Switch
- Exceptional Safe Operating Area
- · Excellent Gain Linearity
- Temperature Independent Switching Performance
- Low Output Capacitance
- \bullet Positive Temperature Coefficient of $R_{\text{DS},\text{ON}}$
- Suitable for Connecting an Anti-parallel Diode

Advantages

- Compatible with Si MOSFET/IGBT Gate Drive ICs
- > 20 µs Short-Circuit Withstand Capability
- Lowest-in-class Conduction Losses
- · High Circuit Efficiency
- Minimal Input Signal Distortion
- High Amplifier Bandwidth

Package

• RoHS Compliant





TO-247

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

Table of Contents

Section I: Absolute Maximum Ratings	
Section II: Static Electrical Characteristics	
Section III: Dynamic Electrical Characteristics	
Section IV: Figures	3
Section V: Driving the GA50JT12-247	
Section VI: Package Dimensions	11
Section VII: SPICE Model Parameters	12

Section I: Absolute Maximum Ratings

Parameter	Symbol	Conditions	Value	Unit	Notes
Drain – Source Voltage	V_{DS}	V _{GS} = 0 V	1200	V	
Continuous Drain Current	I _D	T _C = 25°C	100	Α	Fig. 17
Continuous Drain Current	Ι _D	T _C = 145°C	50	Α	Fig. 17
Continuous Gate Current	I _G		3.5	Α	
Turn-Off Safe Operating Area	RBSOA	T _{VJ} = 175 °C, Clamped Inductive Load	$I_{D,max} = 50$ $\emptyset V_{DS} \le V_{DSmax}$	Α	Fig. 19
Short Circuit Safe Operating Area	SCSOA	T_{VJ} = 175 °C, I_G = 1 A, V_{DS} = 800 V, Non Repetitive	>20	μs	
Reverse Gate – Source Voltage	V_{SG}		30	V	
Reverse Drain – Source Voltage	V_{SD}		25	V	
Power Dissipation	P _{tot}	T_C = 25 °C / 145 °C, t_p > 100 ms	583 / 116	W	Fig. 16
Storage Temperature	T_{stg}		-55 to 175	°C	



Section II: Static Electrical Characteristics

Doromotor	Cumbal	Symbol Conditions		Value		11	Natas
Parameter	Symbol	Conditions	Min. Typical M		Max.	Unit	Notes
A: On State							
Drain – Source On Resistance	R _{DS(ON)}	$I_D = 50 \text{ A}, T_j = 25 ^{\circ}\text{C}$ $I_D = 50 \text{ A}, T_j = 125 ^{\circ}\text{C}$ $I_D = 50 \text{ A}, T_j = 175 ^{\circ}\text{C}$		25 33 43		mΩ	Fig. 5
Gate – Source Saturation Voltage	$V_{GS,SAT}$	$V_{GS,SAT}$ $I_D = 50 \text{ A}, I_D/I_G = 40, T_J = 25 \text{ °C}$ $I_D = 50 \text{ A}, I_D/I_G = 30, T_J = 175 \text{ °C}$		3.42 3.23		V	Fig. 7
DC Current Gain	h _{FE}	$V_{DS} = 5 \text{ V}, I_D = 50 \text{ A}, T_J = 25 \text{ °C}$ $V_{DS} = 5 \text{ V}, I_D = 50 \text{ A}, T_J = 125 \text{ °C}$ $V_{DS} = 5 \text{ V}, I_D = 50 \text{ A}, T_J = 175 \text{ °C}$		95 56 49		-	Fig. 5
B: Off State							
Drain Leakage Current	I _{DSS}	$V_{DS} = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 25 \text{ °C}$ $V_{DS} = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 125 \text{ °C}$ $V_{DS} = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 175 \text{ °C}$		0.1 0.1 0.5		μA	Fig. 8
Gate Leakage Current	I_{SG}	V _{SG} = 20 V, T _j = 25 °C		20		nA	
C: Thermal							
Thermal resistance, junction - case	R_{thJC}			0.26		°C/W	Fig. 20

Section III: Dynamic Electrical Characteristics

D	0	Sumbol Conditions		Value		1114	N - 4
Parameter	Symbol	Conditions	Min.	Typical	Max.	Unit	Notes
A: Capacitance and Gate Charg	e						
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 800 V, f = 1 MHz		7209		pF	Fig. 9
Reverse Transfer/Output Capacitance	C_{rss}/C_{oss}	$V_{DS} = 800 \text{ V}, f = 1 \text{ MHz}$		124		pF	Fig. 9
Output Capacitance Stored Energy	Eoss	$V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V}, f = 1 \text{ MHz}$		40		μJ	Fig. 10
Effective Output Capacitance, time related	$C_{\text{oss,tr}}$	I_D = constant, V_{GS} = 0 V, V_{DS} = 0800 V		231		pF	
Effective Output Capacitance, energy related	$C_{\text{oss,er}}$	V _{GS} = 0 V, V _{DS} = 0800 V		160		pF	
Gate-Source Charge	Q_GS	V _{GS} = -53 V		55		nC	
Gate-Drain Charge	Q_GD	$V_{GS} = 0 \text{ V}, V_{DS} = 0800 \text{ V}$		184		nC	
Gate Charge - Total	Q_{G}			239		nC	
B: Switching ¹							
Internal Gate Resistance – zero bias	$R_{G(INT\text{-}ZERO)}$	f = 1 MHz, V_{AC} = 50 mV, V_{DS} = 0 V, V_{GS} = 0 V, T_j = 175 °C		0.58		Ω	
Internal Gate Resistance – ON	$R_{G(INT-ON)}$	$V_{GS} > 2.5 \text{ V}, V_{DS} = 0 \text{ V}, T_j = 175 \text{ °C}$		0.09		Ω	
Turn On Delay Time	$t_{d(on)}$	_T _i = 25 °C, V _{DS} = 800 V,		50		ns	
Fall Time, V _{DS}	t _f	_I _D = 50 A, Resistive Load		68		ns	Fig. 11, 13
Turn Off Delay Time	$t_{d(off)}$	Refer to Section V for additional		30		ns	
Rise Time, V _{DS}	t _r	driving information.		26		ns	Fig. 12, 14
Turn On Delay Time	$t_{d(on)}$	_		49		ns	
Fall Time, V _{DS}	t _f	$_{\rm T_j}$ = 175 °C, $V_{\rm DS}$ = 800 V,		73		ns	Fig. 11
Turn Off Delay Time	$t_{d(off)}$	I _D = 50 A, Resistive Load		27		ns	
Rise Time, V _{DS}	t _r			28		ns	Fig. 12
Turn-On Energy Per Pulse	Eon	$T_i = 25 ^{\circ}\text{C}, V_{DS} = 800 ^{\circ}\text{V},$		2312		μJ	Fig. 11, 13
Turn-Off Energy Per Pulse	E _{off}	I _D = 50 A, Inductive Load		418		μJ	Fig. 12, 14
Total Switching Energy	E _{tot}	Refer to Section V.		2370		μJ	
Turn-On Energy Per Pulse	E _{on}	T 475.00 W 000 W		2500		μJ	Fig. 11
Turn-Off Energy Per Pulse	E _{off}	T _j = 175 °C, V _{DS} = 800 V, L _D = 50 A, Inductive Load		432		μJ	Fig. 12
Total Switching Energy	E _{tot}	—ip – 557., iliuuolive Loau		2932		μJ	

 $^{^{\}rm 1}$ – All times are relative to the Drain-Source Voltage $\rm V_{\rm DS}$



Section IV: Figures

A: Static Characteristic Figures

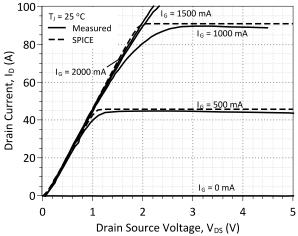


Figure 1: Typical Output Characteristics at 25 °C

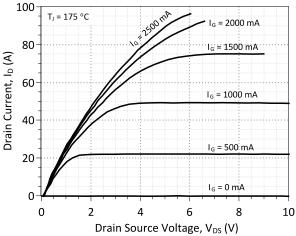


Figure 3: Typical Output Characteristics at 175 °C

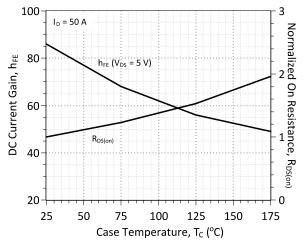


Figure 5: DC Current Gain and Normalized On-Resistance vs. Temperature

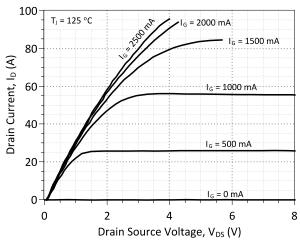


Figure 2: Typical Output Characteristics at 125 °C

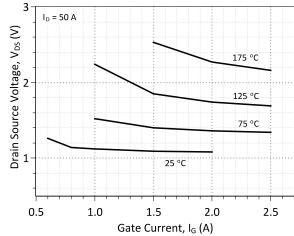


Figure 4: Drain-Source Voltage vs. Gate Current

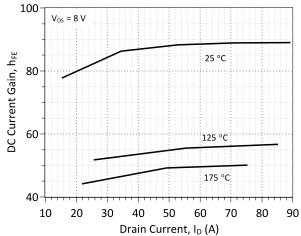


Figure 6: DC Current Gain vs. Drain Current



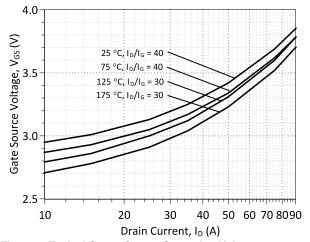


Figure 7: Typical Gate - Source Saturation Voltage

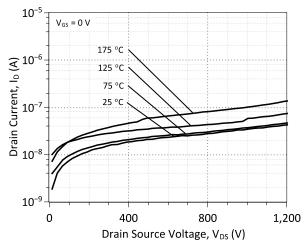


Figure 8: Typical Blocking Characteristics

B: Dynamic Characteristic Figures

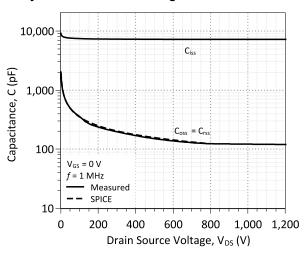


Figure 9: Input, Output, and Reverse Transfer Capacitance

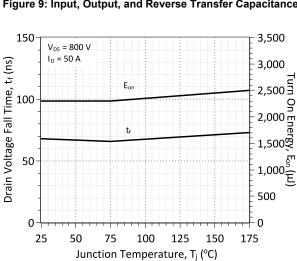


Figure 11: Typical Switching Times and Turn On Energy Losses vs. Temperature

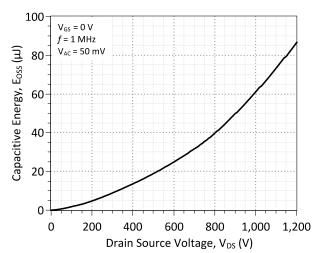


Figure 10: Output Capacitance Stored Energy

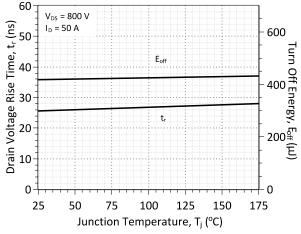


Figure 12: Typical Switching Times and Turn Off Energy Losses vs. Temperature



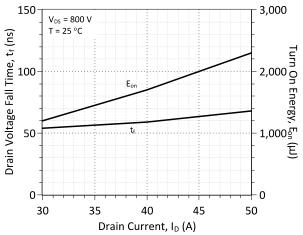


Figure 13: Typical Switching Times and Turn On Energy Losses vs. Drain Current

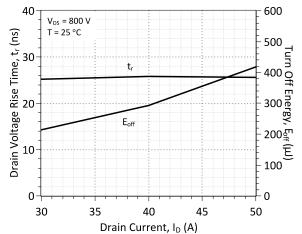


Figure 14: Typical Switching Times and Turn Off Energy Losses vs. Drain Current

C: Device Derating Figures

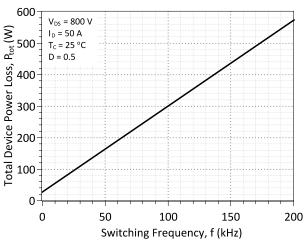


Figure 15: Typical Hard Switched Device Power Loss vs. Switching Frequency ²

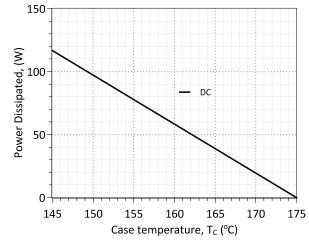


Figure 16: Power Derating Curve

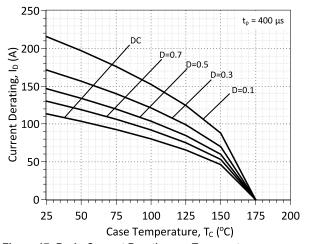


Figure 17: Drain Current Derating vs. Temperature

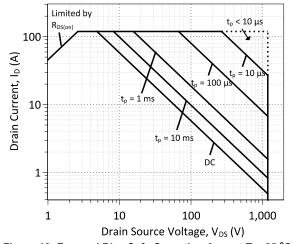


Figure 18: Forward Bias Safe Operating Area at T_c = 25 $^{\circ}$ C

² – Representative values based on device conduction and switching loss. Actual losses will depend on gate drive conditions, device load, and circuit topology.

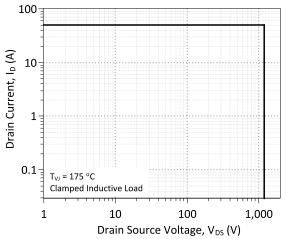


Figure 19: Turn-Off Safe Operating Area

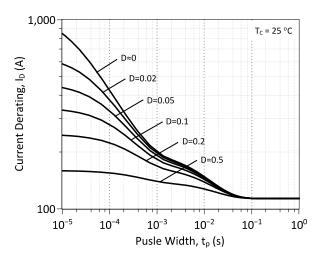


Figure 21: Drain Current Derating vs. Pulse Width

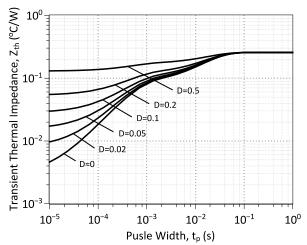


Figure 20: Transient Thermal Impedance



Section V: Driving the GA50JT12-247

Drive Topology	Gate Drive Power Consumption	Switching Frequency	Application Emphasis	Availability
TTL Logic	High	Low	Wide Temperature Range	Coming Soon
Constant Current	Medium	Medium	Wide Temperature Range	Coming Soon
High Speed – Boost Capacitor	Medium	High	Fast Switching	Production
High Speed – Boost Inductor	Low	High	Ultra Fast Switching	Coming Soon
Proportional	Lowest	High	Wide Drain Current Range	Coming Soon
Pulsed Power	Medium	N/A	Pulse Power	Coming Soon

A: Static TTL Logic Driving

The GA50JT12-247 may be driven using direct (5 V) TTL logic after current amplification. The (amplified) current level of the supply must meet or exceed the steady state gate current ($I_{G,steady}$) required to operate the GA50JT12-247. The power level of the supply can be estimated from the target duty cycle of the particular application. $I_{G,steady}$ is dependent on the anticipated drain current ID through the SJT and the DC current gain h_{FE} , it may be calculated from the following equation. An accurate value of the h_{FE} may be read from Figure 6.

$$I_{G,steady} \approx \frac{I_D}{h_{FE}(T,I_D)} * 1.5$$

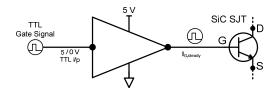


Figure 22: TTL Gate Drive Schematic

B: High Speed Driving

The SJT is a current controlled transistor which requires a positive gate current for turn-on as well as to remain in on-state. An ideal gate current waveform for ultra-fast switching of the SJT, while maintaining low gate drive losses, is shown in Figure 23 which features a positive current peak during turn-on, a negative current peak during turn-off, and continuous gate current to remain on.

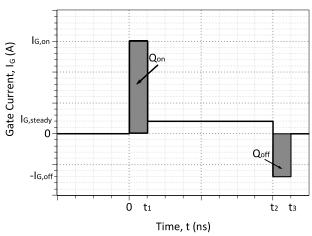


Figure 23: An idealized gate current waveform for fast switching of an SJT.

An SJT is rapidly switched from its blocking state to on-state, when the necessary gate charge, Q_G , for turn-on is supplied by a burst of high gate current, $I_{G,on}$, until the gate-source capacitance, C_{GS} , and gate-drain capacitance, C_{GD} , are fully charged.

$$Q_{on} = I_{G,on} * t_1$$

$$Q_{on} \ge Q_{as} + Q_{ad}$$



Ideally, $I_{G,pon}$ should terminate when the drain voltage falls to its on-state value in order to avoid unnecessary drive losses during the steady on-state. In practice, the rise time of the $I_{G,on}$ pulse is affected by the parasitic inductances, L_{par} in the device package and drive circuit. A voltage developed across the parasitic inductance in the source path, L_s , can de-bias the gate-source junction, when high drain currents begin to flow through the device. The voltage applied to the gate pin should be maintained high enough, above the $V_{GS,sat}$ (see Figure 7) level to counter these effects.

A high negative peak current, $-I_{G,off}$ is recommended at the start of the turn-off transition, in order to rapidly sweep out the injected carriers from the gate, and achieve rapid turn-off. While satisfactory turn off can be achieved with $V_{GS} = 0$ V, a negative gate voltage V_{GS} may be used in order to speed up the turn-off transition.

Two high-speed drive topologies for the SiC SJTs are presented below.

B:1: High Speed, Low Loss Drive with Boost Capacitor, GA03IDDJT30-FR4

The GA50JT12-247 may be driven using a High Speed, Low Loss Drive with Boost Capacitor topology in which multiple voltage levels, a gate resistor, and a gate capacitor are used to provide fast switching current peaks at turn-on and turn-off and a continuous gate current while in on-state. A 3 kV isolated evaluation gate drive board (GA03IDDJT30-FR4) utilizing this topology is commercially available for high and low-side driving, its datasheet provides additional details about this drive topology.

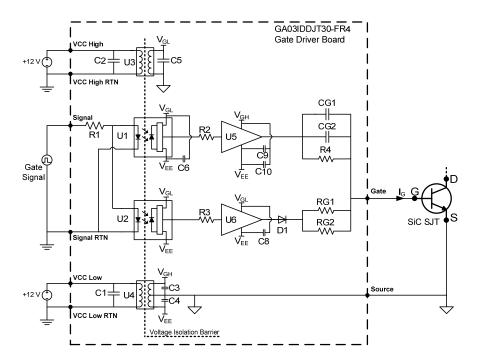


Figure 24: Topology of the GA03IDDJT30-FR4 Two Voltage Source gate driver.

The GA03IDDJT30-FR4 evaluation board comes equipped with two on board gate drive resistors (RG1, RG2) pre-installed for an effective gate resistance³ of R_G = 3.75 Ω . It may be necessary for the user to reduce RG1 and RG2 under high drain current conditions for safe operation of the GA50JT12-247. The steady state current supplied to the gate pin of the GA50JT12-247 with on-board R_G = 3.75 Ω , is shown in Figure 25. The maximum allowable safe value of R_G for the user's required drain current can be read from Figure 26.

For the GA50JT12-247, R_G must be reduced for I_D ≥ ~14 A for safe operation with the GA03IDDJT30-FR4.

For operation at $I_D \ge \sim 14$ A, R_G may be calculated from the following equation, which contains the DC current gain h_{FE} (Figure 6) and the gate-source saturation voltage $V_{GS,sat}$ (Figure 7).

$$R_{G,max} = \frac{\left(4.7V - V_{GS,sat}\right) * h_{FE}(T, I_D)}{I_D * 1.5} - 0.6\Omega$$

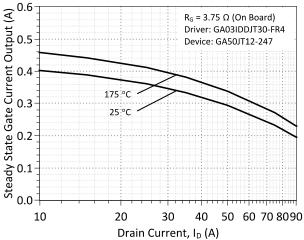


Figure 25: Typical steady state gate current supplied by the GA03IDDJT30-FR4 board for the GA50JT12-247 with the on board resistance of 3.75 Ω

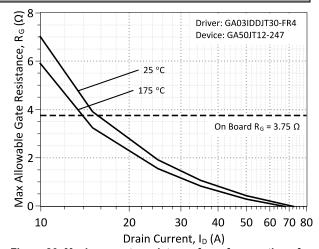


Figure 26: Maximum gate resistance for safe operation of the GA50JT12-247 at different drain currents using the GA03IDDJT30-FR4 board.

B:2: High Speed, Low Loss Drive with Boost Inductor

A High Speed, Low-Loss Driver with Boost Inductor is also capable of driving the GA50JT12-247 at high-speed. It utilizes a gate drive inductor instead of a capacitor to provide the high-current gate current pulses $I_{G,on}$ and $I_{G,off}$. During operation, inductor L is charged to a specified $I_{G,on}$ current value then made to discharge I_L into the SJT gate pin using logic control of S_1 , S_2 , S_3 , and S_4 , as shown in Figure 27. After turn on, while the device remains on the necessary steady state gate current $I_{G,steady}$ is supplied from source V_{CC} through R_G . Please refer to the article "A current-source concept for fast and efficient driving of silicon carbide transistors" by Dr. Jacek Rąbkowski for additional information on this driving topology.⁴

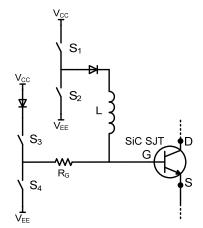


Figure 27: Simplified Inductive Pulsed Drive Topology

 $^{^3}$ – R_G = (1/RG1 +1/RG2) 1 . Driver is pre-installed with RG1 = RG2 = 7.5 Ω

⁴ – Archives of Electrical Engineering. Volume 62, Issue 2, Pages 333–343, ISSN (Print) 0004-0746, DOI: 10.2478/aee-2013-0026, June 2013



C: Proportional Gate Current Driving

For applications in which the GA50JT12-247 will operate over a wide range of drain current conditions, it may be beneficial to drive the device using a proportional gate drive topology to optimize gate drive power consumption. A proportional gate driver relies on instantaneous drain current I_D feedback to vary the steady state gate current $I_{G,steady}$ supplied to the GA50JT12-247

C:1: Voltage Controlled Proportional Driver

The voltage controlled proportional driver relies on a gate drive IC to detect the GA50JT12-247 drain-source voltage V_{DS} during on-state to sense I_D . The gate drive IC will then increase or decrease $I_{G,steady}$ in response to I_D . This allows $I_{G,steady}$, and thus the gate drive power consumption, to be reduced while I_D is relatively low or for $I_{G,steady}$ to increase when is I_D higher. A high voltage diode connected between the drain and sense protects the IC from high-voltage when the driver and GA50JT12-247 are in off-state. A simplified version of this topology is shown in Figure 29, additional information will be available in the future at http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/

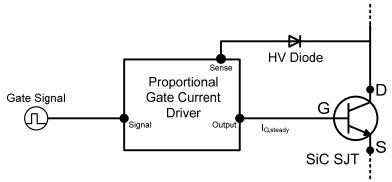


Figure 28: Simplified Voltage Controlled Proportional Driver

C:2: Current Controlled Proportional Driver

The current controlled proportional driver relies on a low-loss transformer in the drain or source path to provide feedback I_D of the GA50JT12-247 during on-state to supply $I_{G,steady}$ into the device gate. $I_{G,steady}$ will then increase or decrease in response to I_D at a fixed forced current gain which is set be the turns ratio of the transformer, $h_{force} = I_D / I_G = N_2 / N_1$. GA50JT12-247 is initially tuned-on using a gate current pulse supplied into an RC drive circuit to allow I_D current to begin flowing. This topology allows $I_{G,steady}$, and thus the gate drive power consumption, to be reduced while I_D is relatively low or for $I_{G,steady}$ to increase when is I_D higher. A simplified version of this topology is shown in Figure 29, additional information will be available in the future at http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/.

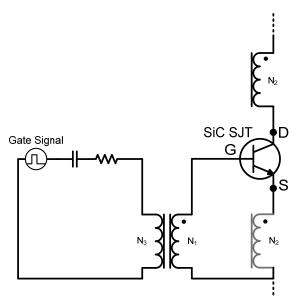
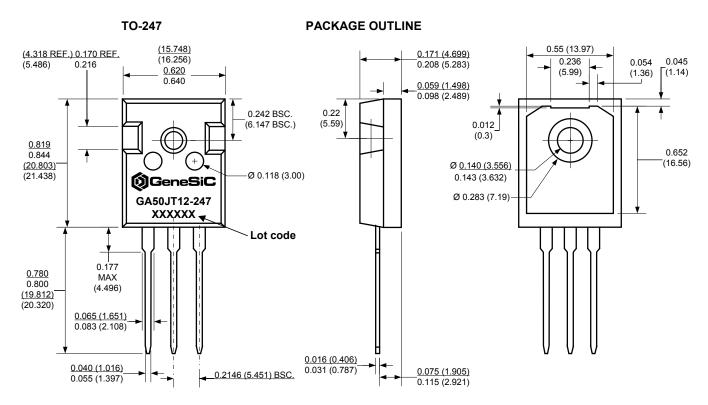


Figure 29: Simplified Current Controlled Proportional Driver



Section VI: Package Dimensions



NOTE

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History						
Date Revision Comments Supersedes						
2014/11/12	1	Updated Electrical Characteristics				
2014/08/25	0	Initial release				

Published by GeneSiC Semiconductor, Inc. 43670 Trade Center Place Suite 155 Dulles, VA 20166

GeneSiC Semiconductor, Inc. reserves right to make changes to the product specifications and data in this document without notice.

GeneSiC disclaims all and any warranty and liability arising out of use or application of any product. No license, express or implied to any intellectual property rights is granted by this document.

Unless otherwise expressly indicated, GeneSiC products are not designed, tested or authorized for use in life-saving, medical, aircraft navigation, communication, air traffic control and weapons systems, nor in applications where their failure may result in death, personal injury and/or property damage.



Section VII: SPICE Model Parameters

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/products_sic/sjt/GA50JT12-247_SPICE.pdf) into LTSPICE (version 4) software for simulation of the GA50JT12-247.

```
MODEL OF GeneSiC Semiconductor Inc.
     $Revision:
                   2.0
                                 $
     $Date: 25-AUG-2014
                                 Ś
     GeneSiC Semiconductor Inc.
     43670 Trade Center Place Ste. 155
     Dulles, VA 20166
     COPYRIGHT (C) 2014 GeneSiC Semiconductor Inc.
     ALL RIGHTS RESERVED
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
.model GA50JT12 NPN
+ IS
           5.00E-47
+ ISE
           1.26E-28
+ EG
          3.23
+ BF
           91
+ BR
           0.55
           9000
+ IKF
+ NF
           1
           2
+ NE
+ RB
          0.95
+ IRB
           0.005
+ RBM
           0.073
          0.005
+ RE
+ RC
           0.014
+ CJC
          2.398E-9
           2.8346
+ VJC
+ MJC
           0.4846
          6.026E-09
+ CJE
           3.1791
+ VJE
          0.5295
+ MJE
+ XTI
           3
           -1.5
+ XTB
           9.00E-3
+ TRC1
           1200
+ VCEO
+ ICRATING 50
+ MFG
       GeneSiC Semiconductor
```

* End of GA50JT12 SPICE Model